

ENGINEERING TEST REPORT

SEP. 12, 2002

Report No. CALR-FCC-215

This is to certify that the MICROWAVE OVEN from which the following data has been derived properly complies with the requirements of " FCC Rules and Regulations Part 18 Subpart C " as of the date the measurements were made.

1. Manufacturer of Device : Shanghai Matsushita Microwave Oven Company Ltd.

898 Long Dong Road, Shanghai
Shanghai 201203, China

2. Description of Device

a. FCC ID.	:	ACLAP5Y01
b. Model No.	:	NN-S563BF
c. Serial No.	:	PP00001
d. Operating Frequency	:	2450 MHz
e. Output RF Power	:	1350 W (BY IEC 705)
f. Power Consumption	:	120 V. 60 Hz
g. Magnetron Type	:	Matsushita 2M261
h. Employed Mode	:	Turn table
i. Door Seal Type	:	Choke

3. Measurement Procedure Used : FCC/OST MP-5

4. Measurement Site

Name : Panasonic Magnetron Lab.
Panasonic Industrial Company

Address : 1707 N. Randall Road
Elgin, Illinois 60123-7847

Description of this test facility has been filed with the FCC. (Feb. 26, 1987,
File # 31010/EQU 4-3-0A)

5. Date of Measurement : SEP. 12, 2002

6. Measurement Data : See Attached " Data Summary "

Tested By



M. Okamoto
Applications Manager of Magnetron
Panasonic Industrial Company

ENGINEERING TEST REPORT

NOV. 19, 2002

Report No. CALR-FCC-218

This is to certify that the MICROWAVE OVEN from which the following data has been derived properly complies with the requirements of " FCC Rules and Regulations Part 18 Subpart C " as of the date the measurements were made.

1. Manufacturer of Device : Shanghai Matsushita Microwave Oven Company Ltd.

898 Long Dong Road, Shanghai
Shanghai 201203, China

2. Description of Device

a. FCC ID.	:	ACLAP5R01
b. Model No.	:	NN-S443WF
c. Serial No.	:	FE002
d. Operating Frequency	:	2450 MHz
e. Output RF Power	:	1200 W (BY IEC 705)
f. Power Consumption	:	120 V. 60 Hz
g. Magnetron Type	:	Matsushita 2M261
h. Employed Mode	:	Turn table
i. Door Seal Type	:	Choke

3. Measurement Procedure Used : FCC/OST MP-5

4. Measurement Site

Name : Panasonic Magnetron Lab.
Panasonic Industrial Company

Address : 1707 N. Randall Road
Elgin, Illinois 60123-7847

Description of this test facility has been filed with the FCC. (Feb. 26, 1987,
File # 31010/EQU 4-3-0A)

5. Date of Measurement : NOV. 19, 2002

6. Measurement Data : See Attached " Data Summary "

Tested By



M. Okamoto
Applications Manager of Magnetron
Panasonic Industrial Company